



SLOVENSKI STANDARD
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01-oktober-2024

Magnetni materiali - 18. del: Materiali za permanentne (trdomagnetne) magnete - Metode merjenja magnetnih lastnosti v odprtem magnetnem krogu z uporabo superprevodnega magneta

Magnetic materials - Part 18: Permanent magnet (magnetically hard) materials - Methods of measurement of the magnetic properties in an open magnetic circuit using a superconducting magnet

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Matériaux magnétiques - Partie 18: Matériaux (magnétiques durs) pour aimants permanents - Méthodes de mesure des propriétés magnétiques en circuit magnétique ouvert à l'aide d'un aimant supraconducteur

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TITLE:

Magnetic materials - Part 18: Permanent magnet (magnetically hard) materials - Methods of measurement of the magnetic properties in an open magnetic circuit using a superconducting magnet

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This CDV document was prepared by the Project Leader on the basis of the second CD and the comments received from National Committees (see 68/767/CC) and the contributions from the Project Team, following the decision made by the TC 68 Chairman.

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

MAGNETIC MATERIALS –**Part 18: Permanent magnet (magnetically hard) materials –
Methods of measurement of the magnetic properties in an open
magnetic circuit using a superconducting magnet**

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123 IEC 60404-18 has been prepared by IEC technical committee 68: Magnetic alloys and steels.
124 It is an International Standard.

125 The text of this International Standard is based on the following documents:

Draft	Report on voting
68/XX/FDIS	68/XX/RVD

126
127 Full information on the voting for its approval can be found in the report on voting indicated in
128 the above table.

129 The language used for the development of this International Standard is English.

130 This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in
131 accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available
132 at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are
133 described in greater detail at www.iec.ch/publications.

134 A list of all parts in the IEC 60404 series, published under the general title *Magnetic materials*,
135 can be found on the IEC website.

136 The committee has decided that the contents of this document will remain unchanged until the
137 stability date indicated on the IEC website under webstore.iec.ch in the data related to the
138 specific document. At this date, the document will be

- 139 • reconfirmed,
- 140 • withdrawn,
- 141 • replaced by a revised edition, or
- 142 • amended.

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INTRODUCTION

145 High-performance permanent magnet materials with high coercivity, e.g. Nd-Fe-B magnets,
146 have been used in the electric and automobile industry and its usage increases rapidly to meet
147 the need to improve energy saving and to increase efficiency of electromagnetic applications,
148 e.g. traction motors for Electric Vehicle (EV) and Hybrid Electric Vehicle (HEV), which are
149 urgently demanded to contribute to the problem of global warming.

150 However, there has been no standard method which can determine all the magnetic properties
151 of the high-performance permanent magnet materials with coercivity H_{cJ} higher than 2 MA/m to
152 meet the need of the industry. The method specified in IEC 60404-5, which is a method of
153 measurement in a closed magnetic circuit, can lead to significant measurement errors for
154 measurement of $H_{cJ} \geq 1,6$ MA/m due to magnetic saturation in parts of the pole faces of the
155 yoke (see IEC 60404-5).

156 In order to solve the problem, several methods of measurement in an open magnetic circuit
157 without a yoke have been developed. The methods using a superconducting magnet (SCM) are
158 thought to solve this problem and enable accurate measurements of the high-performance
159 permanent magnet materials (see IEC TR 63304:2021 [1]¹).

160 Since the measurement in an open magnetic circuit is strongly affected by the self-
161 demagnetizing field in the test specimen, a correction of the influence of self-demagnetizing
162 field (demagnetizing field correction) on the demagnetization curve obtained in an open
163 magnetic circuit is indispensable.

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¹ Numbers in square brackets refer to the Bibliography.

MAGNETIC MATERIALS –

Part 18: Permanent magnet (magnetically hard) materials – Methods of measurement of the magnetic properties in an open magnetic circuit using a superconducting magnet

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173 **1 Scope**

174 The purpose of this part of IEC 60404 is to define the general principle and technical details of
175 the methods of measurement of the DC magnetic properties of permanent magnet materials in
176 an open magnetic circuit using a superconducting magnet (SCM).

177 This method is applicable to permanent magnet materials, such as those specified in
178 IEC 60404-8-1, the properties of which are presumed homogeneous throughout their volume.

179 There are two methods:

- 180 – the SCM-Vibrating Sample Magnetometer (VSM) method;
- 181 – the SCM-Extraction method.

182 This document also specifies methods to correct the influence of the self-demagnetizing field
183 in the test specimen on the demagnetization curve obtained in an open magnetic circuit. The
184 magnetic properties are determined from the corrected demagnetization curve.

185 NOTE 1 These SCM-methods can determine the magnetic properties of high-performance permanent magnet
186 materials with coercivity higher than 2 MA/m. For the magnetic materials with coercivity higher than 1,6 MA/m, the
187 methods of measurement in a closed magnetic circuit in accordance with IEC 60404-5 can lead to significant
188 measurement error due to magnetic saturation in parts of the pole faces of the yoke (see IEC 60404-5).

189 NOTE 2 There is another method of the measurement in an open magnetic circuit, i.e. the pulsed field
190 magnetometer (PFM), which is described in IEC TR 62331[3]. The PFM is the method of measurement of the magnetic
191 properties of permanent magnet materials applying the pulsed magnetic field instead of the DC magnetic field and is
192 different from the methods described in this document. The PFM measures a steep AC magnetic response of a test
193 specimen in a pulsed magnetic field. Consequently, additional correction is indispensable to remove the influence of
194 eddy currents in the test specimen and the magnetic viscosity of the magnetic materials in order to obtain properties
195 equivalent to the DC magnetic properties.

196 **2 Normative references**

197 The following documents are referred to in the text in such a way that some or all of their content
198 constitutes requirements of this document. For dated references, only the edition cited applies.
199 For undated references, the latest edition of the referenced document (including any
200 amendments) applies.

201 IEC 60404-5, *Magnetic materials – Part 5: Permanent magnet (magnetically hard) materials –*
202 *Methods of measurement of magnetic properties*

203 IEC 60404-8-1, *Magnetic materials – Part 8-1: Specifications for individual materials –*
204 *Magnetically hard materials*

205 IEC 60050-121, *International Electrotechnical Vocabulary – Part 121: Electromagnetism*

206 IEC 60050-151, *International Electrotechnical Vocabulary – Part 151: Electrical and magnetic*
207 *devices*

208 IEC 60050-221, *International Electrotechnical Vocabulary – Chapter 221: Magnetic materials*
209 *and components*

210 **3 Terms and definitions**

211 For the purposes of this document, the terms and definitions given in IEC 60050-121,
212 IEC 60050-151, IEC 60050-221 and the following apply.

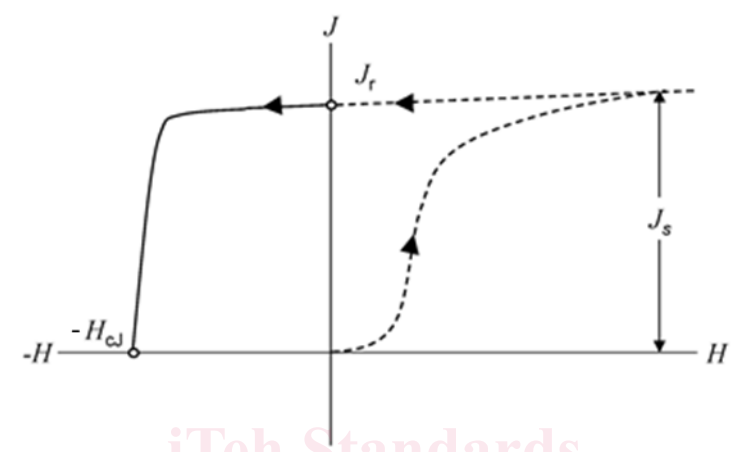
213 ISO and IEC maintain terminological databases for use in standardization at the following
214 addresses:

- 215 • IEC Electropedia: available at <http://www.electropedia.org/>
- 216 • ISO Online browsing platform: available at <http://www.iso.org/obp>

217 3.1

218 demagnetization curve

219 part of a hysteresis loop in which the magnetic polarization goes from the remanent magnetic
220 polarization to zero when the applied magnetic field strength varies monotonically, as illustrated
221 in Figure 1



222

223 Key

- 224 J_s saturation magnetic polarization, in T
- 225 J_r remanent magnetic polarization, in T
- 226 H_{cJ} coercivity relating to the magnetic polarization, in A/m

227

Figure 1 – Demagnetization curve $J(H)$

228 Note 1 to entry: A demagnetization curve can be drawn from near magnetic saturation.

229 [SOURCE: IEC 60050-121:1998, 121-12-72, modified – magnetic flux density is replaced by
230 magnetic polarization and Note 1 to entry and Figure 1 have been added]

231 3.2

232 magnetic dipole moment

233 m

234 vector quantity given by the volume integral of the magnetic polarization

235 [SOURCE: IEC 60050-221:1990, 221-01-07, modified – the symbol j is changed to m which is
236 used industrially and the note has been removed]

237 3.3

238 M coil

239 detection coil for magnetic dipole moment

240 4 General principle

241 4.1 Principle of the method

242 Figure 2 illustrates schematic diagrams of the test apparatus corresponding to a) the SCM-VSM
243 method and b) the SCM-Extraction method. The test apparatus consists of a superconducting
244 magnet (SCM), a moving device, a specimen rod, a magnetic field sensor (hereafter H sensor),
245 a magnetic dipole moment detection coil (hereafter M coil), measuring devices and a data
246 processing device (PC).

247 The axis of the DC magnetic field generated by the SCM shall be vertical and coaxial with the
248 M coil and the specimen rod so that the direction of magnetization is parallel to the axis of the

